

Form PTO-1449

U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICEATTY. DOCKET NO.
M122-1786SERIAL NO.
09/935,465

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U.S. PATENT DOCUMENTS

*Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
<i>[Signature]</i>	AA	6,271,498	8/2001	Miyake et al			
	AB	6,110,531	8/2000	Paz De Arzujo et al			
	AC	6,051,286	4/2000	Zhao et al			
	AD	6,083,557	7/2000	Belcher et al			
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						

FOREIGN PATENT DOCUMENTS

		Document Number	Date	Country	Class	Subclass	Translation	
							Yes	No
	AM							
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	AO							
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OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)

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M122-1786SERIAL NO.
09/935,465LIST OF ART CITED BY APPLICANT
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Eugene P. MarshFILING DATE
August 21, 2001GROUP
1762

U.S. PATENT DOCUMENTS

Examiner Initial	Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
HC	AA 5,052,339	10/1991	Vakerlis et al			
	AB 5,952,060	09/1999	Ravi			
	AC 5,374,314	12/1994	Babacz			
	AD 4,526,805	07/1985	Yoshizawa			
	AE 5,891,349	04/1999	Tobe et al			
	AF 6,216,708	04/2001	Agarwal			
	AG 6,379,575	04/2002	Yin et al			
	AH Re 35,785	05/1998	Sandhu et al			
	AI					
	AJ					
	AK					
	AL					

FOREIGN PATENT DOCUMENTS

	Document Number	Date	Country	Class	Subclass	Translation	
						Yes	No
BM	JP04107826A	04/1992	Japan				X
	AN JP411012740A	01/1999	Japan				X
	AO JP02000087243A	03/2000	Japan				X
	AP						
	AQ						

OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)

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EXAMINER	DATE CONSIDERED 3/6/03	

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Form PTO-1449		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		Priority ATTY. DOCKET NO. MI22\1786	Priority SERIAL NO. 09/352,817
LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT Eugene P. Marsh	
				Priority FILING DATE July 13, 1999	Priority GROUP 1762

U.S. PATENT DOCUMENTS							
*Examiner Initial	Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate	
P	AA	5,356,478	10/1994	Chen et al.			
	AB	5,882,424	03/1999	Taylor et al.			
	AC	5,788,799	08/1998	Steger et al.			
	AD	5,647,953	07/1997	Williams et al.			
	AE	5,882,416	03/1999	Van Buskirk et al.			
	AF	5,362,328	11/1994	Gardiner			
	AG	5,983,906	11/99	Zhao et al.			
	AH	6,014,979	01/00	Van Autryve et al.			
	AI	5,523,261	06/96	Sandhu			
	AJ	5,616,208	04/97	Lee			
U	AK	6,060,397	05/00	Seamons et al.			
	AL	6,125,859	10/00	Kao et al.			

FOREIGN PATENT DOCUMENTS							
Document Number	Date	Country	Class	Subclass	Translation		
					Yes	No	
AM							
AN							
AO							
AP							
AQ							

OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)		
AR		"Handbook of Thin-Film Deposition Processes and Techniques", edited by Kaus Schuegraf. Noyes Publications, New Jersey, pp. 6-7, 1988.
AS		
AT		

EXAMINER	DATE CONSIDERED

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